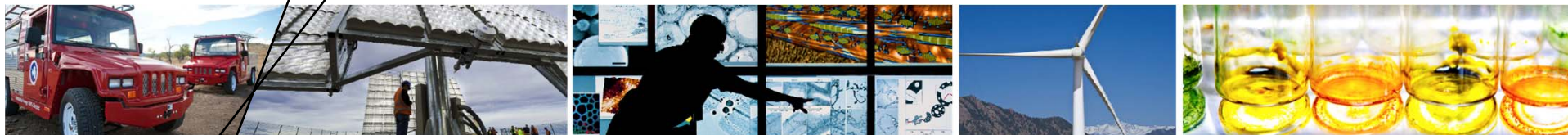


# CIGS Material and Device Stability: A Processing Perspective



**Kannan Ramanathan, NCPV**

**PV Module Reliability Workshop, March 1, 2012  
Golden, Colorado**

**NREL/PR-5200-54569**

# CIGS landscape

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- **Multiple companies trying to get to high volume, low-cost manufacturing. Challenged to increase efficiency, control variability and ensure reliability. Efficiency bar is rising.**
- **Diverse approaches, cell designs. Different stages of maturity. Process details largely proprietary.**
- **Process control and understanding of ‘cause and effect’ still needed, desired.**
- **Precursor selenization/sulfurization and co-evaporation based processes have an edge.**

# Connecting the pieces

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- **Solar cell fabrication method, tool, process details**
- **Process to property correlation**
- **Cause and effect analysis of variability**
- **Performance improvement**
- **Device level changes and mitigation**
- **Packaging/ Protection of circuits**
- **Above pieces are connected, must work together to address stability issues.**

# Stability Topics

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- **Light soaking**
- **Post lamination loss**
- **Changes due to moisture ingress**
- **Reverse bias leakage**
- **Shunts**
- **Hot spots**
- **Weak diodes**

# Outline

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- **CIGS Material Properties: Basics**
- **CIGS Devices: Basic features**
- **Cell level changes**
- **Examples of previous work**
- **What do we need to measure? Interpret?  
Improve?**

# CIGS(S) Absorber

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- **Quaternary and pentenary alloys derived from base compound  $\text{CuInSe}_2$ . Band gap is increased by alloying with Ga and/or S.**
- **Band gap may not be uniform across the depth of the film, often graded.**
- **Phase purity and stoichiometry are important to control.**
- **Single crystal/ epi knowledge base is weak.**
- **Adequate working knowledge of physical and electronic properties, bear great resemblance to II-VI 'parents'.**

# Absorber: desired properties, process

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- **Durable metal contact to the p-side (Mo)**
  - Minimally reactive, ohmic contact stabilized by  $\text{MoSe}_2$ .
  - Needs proper process conditions to be the best
- **P-type absorber**
  - Doping by native defects (close compensation)
  - Some elements enhance p-type doping (Na, Sb)
  - Higher temperature growth preferred
  - Chalcogen rich growth preferred
  - Crystal quality = efficiency (stability?)

# Absorber: Electrical

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- **CuInSe<sub>2</sub> can be n- or p-type**
- **Thin films are p-type when grown Cu-poor in Se-rich conditions.**
- **With Ga and Na included, p-type is likely stabilized.**
- **If grown in Se-poor conditions, material can be high resistivity p-type or even n-type (more compensation, low lifetime).**
- **Electrical properties are a sensitive function of the growth method, tool, recipe.**
- **No direct measure of absorber's electrical properties!**



# Junction

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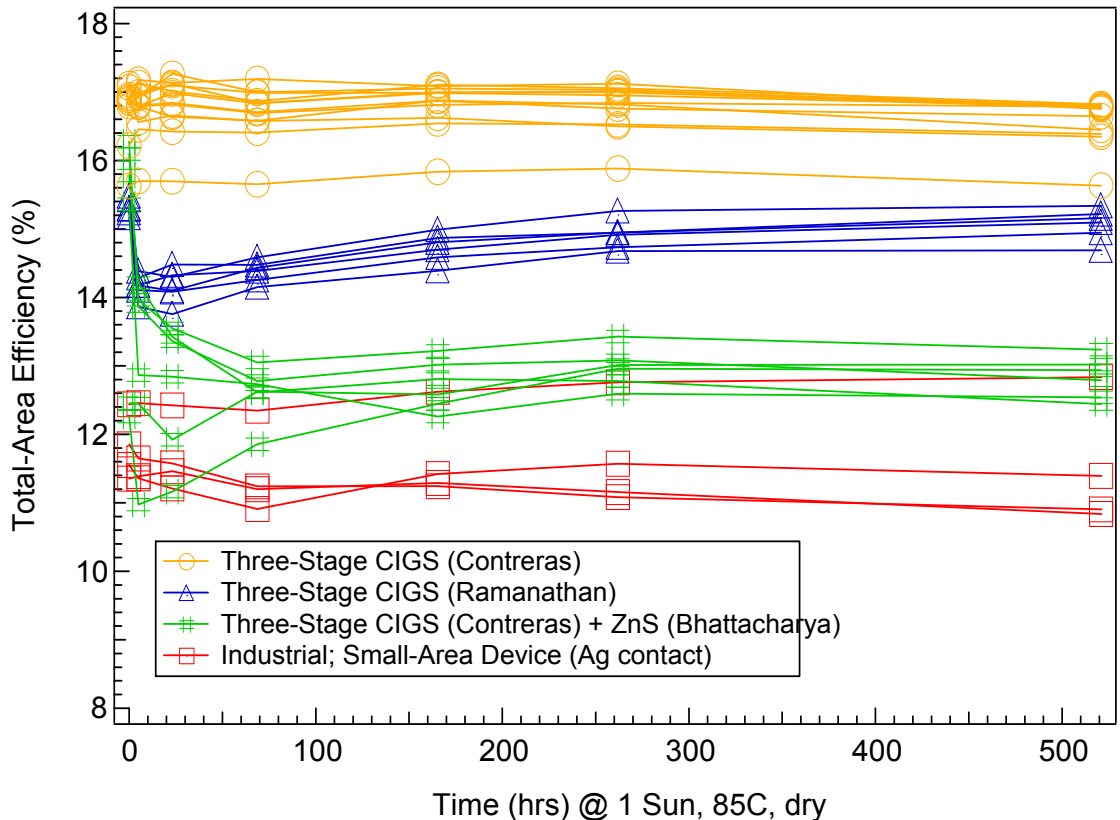
- **Chemically grown CdS layers form the n-type emitter. Preferred junction partner.**
- **CBD bath induces change in electronic properties in addition to the growth of a compatible “buffer layer”**
- **Alternative emitter layers (ZnOS,  $\text{In}_2\text{S}_3$ ) promising, come with unique characteristics.**
- **ZnO conductivity can degrade upon carrier compensation.**

# Device stability/ Metastability

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- **1992: Siemens Solar asked for help in understanding “transient effects”**
  - Device properties changed dramatically when exposed to light, voltage bias etc.
- **2012: Similar products in vogue, exhibit similar characteristics.**
- **Device characteristics are a function of how they are made. NREL ≠ Miasole ≠ Stion. Specifics of each device to be taken into account when solving cell/ module optimization.**

# Prior NREL work: D. Albin



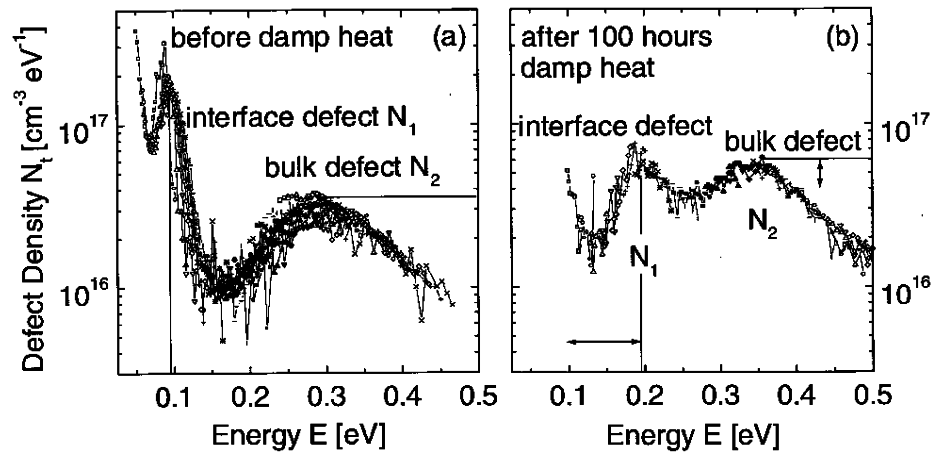
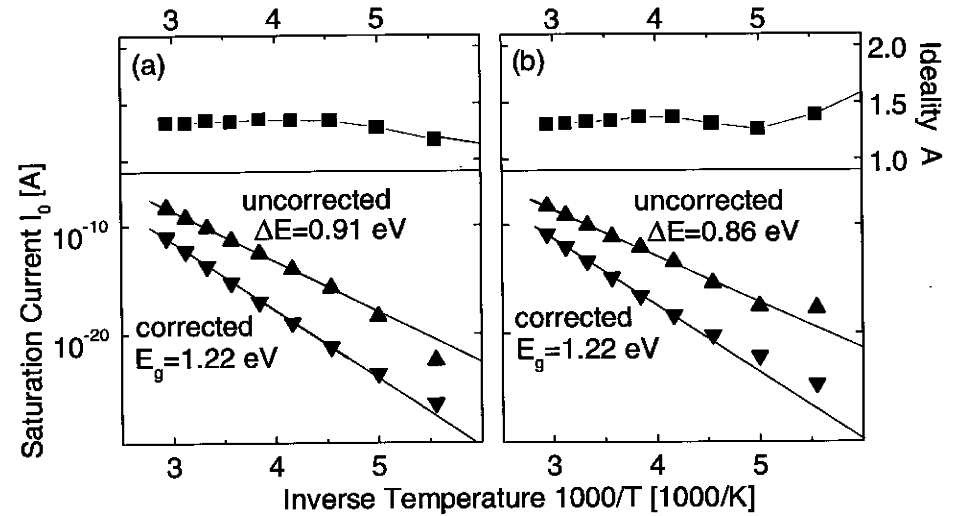
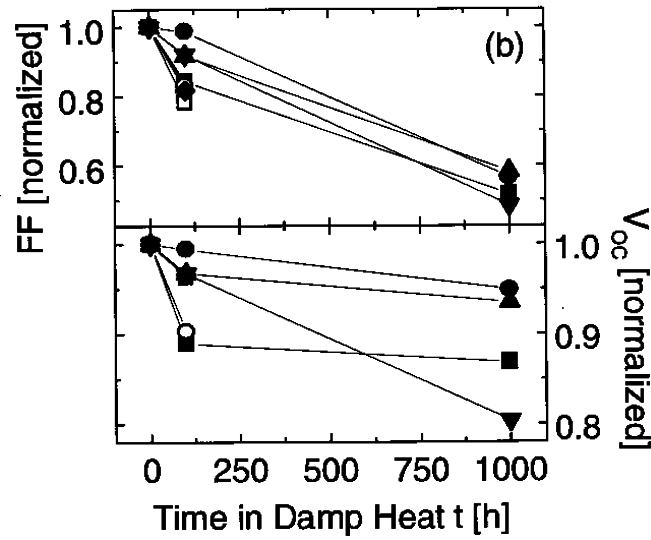
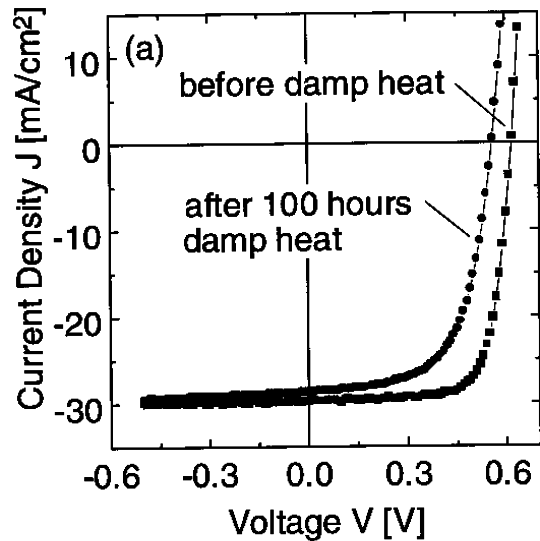
identical 3-stage process; yet very different transient recovery behavior; distinguishing difference = Mo

Modified “ZnS” junction; different characteristics on the same substrate

“industrial” samples showed biggest spread in light-soak behavior

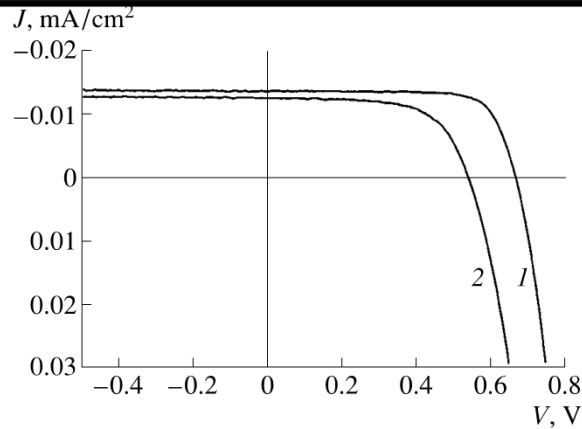
All devices show attainment of a “stabilized” level

# Cell in DH; no encapsulation

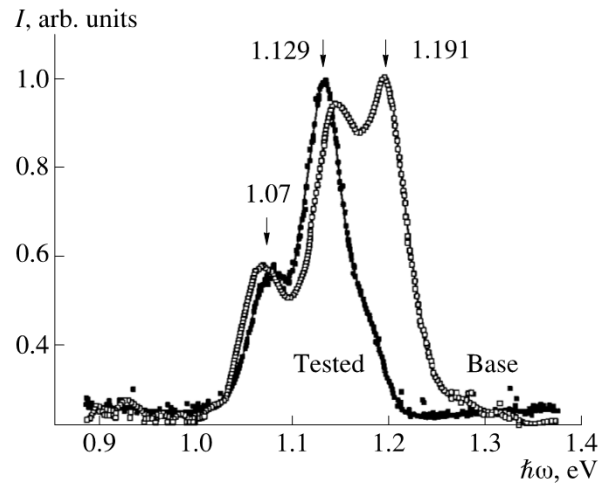


M. Schmidt et al. / Thin Solid Films 361±362 (2000) 283±287

# PL of cells after damp heat exposure



**Fig. 1.** Load characteristic of solar cells (1) prior to and (2) after treatment in a humid atmosphere at an elevated temperature. The measurement temperature  $T = 25^\circ\text{C}$ .



**Fig. 2.** PL spectra of CIGS solar cells prior to and after heating in humid atmosphere. The measurement temperature  $T = 20 \text{ K}$ , the excitation wavelength  $\lambda = 532 \text{ nm}$ , and the excitation power is  $50 \text{ mW}$ . Characteristic energies are given in  $\text{eV}$ .

DH effects:

- Decrease in absorber doping (increase in defect level density)
- Increase in junction recombination

# Light soaking: early Siemens cells

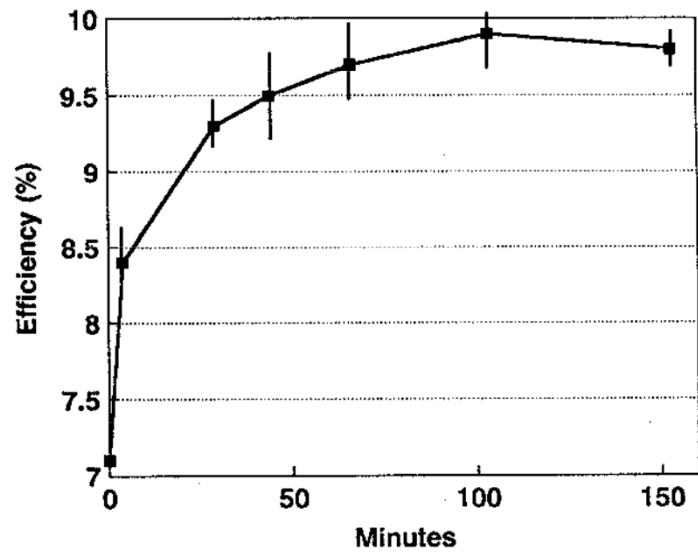


Fig. 6. Efficiency gains during light soaking by eight relatively poor CIS cells.

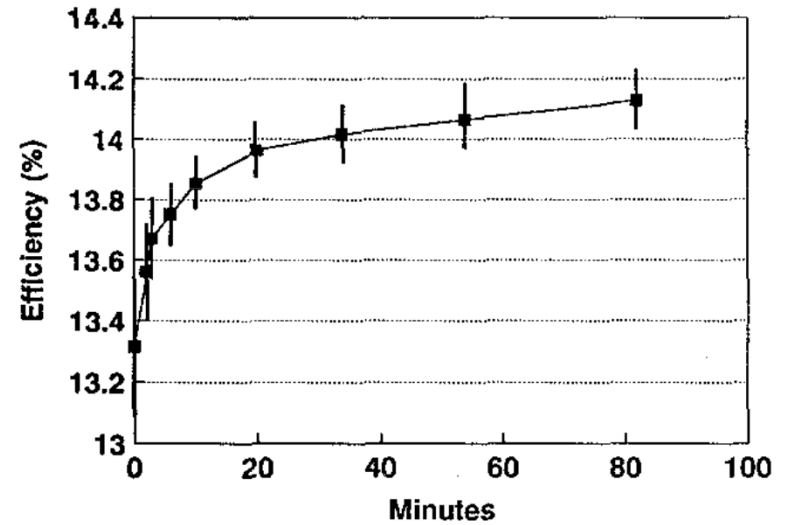
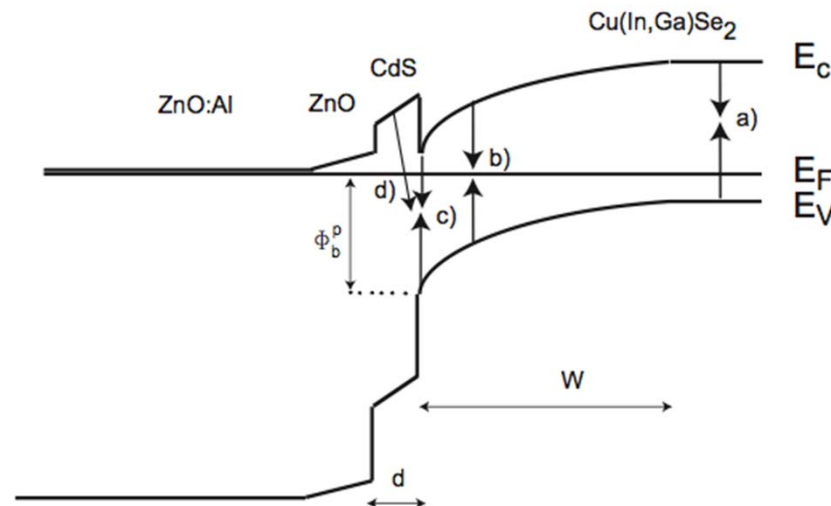
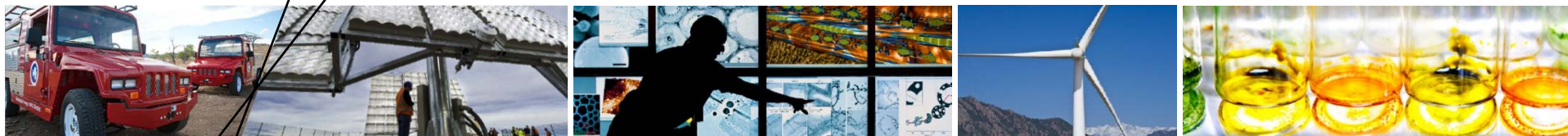


Fig. 7. Efficiency as a function of light soaking of 16 cells of high efficiency CuInSe<sub>2</sub> based materials.

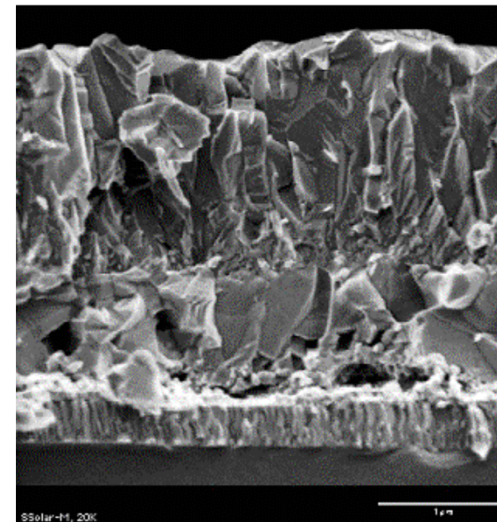
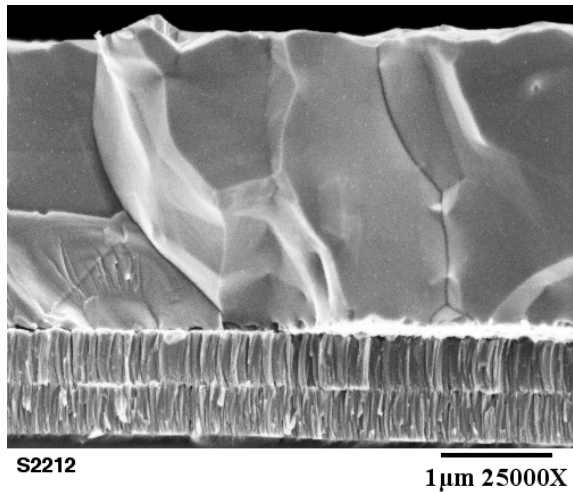
D. Willett, IEEE PVSC, 1993





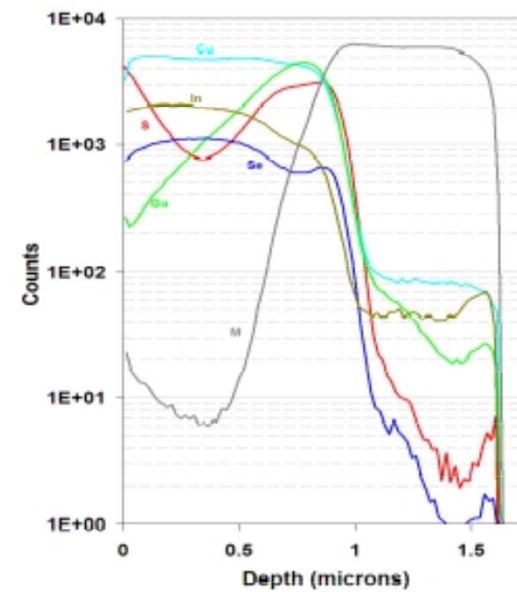
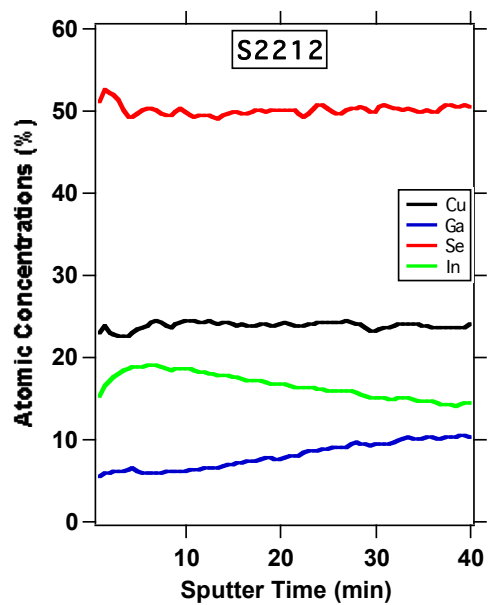
**Process understanding/ quality  
improvement:  
Case studies from past NREL work**

# Comparison of NREL and SSI absorbers



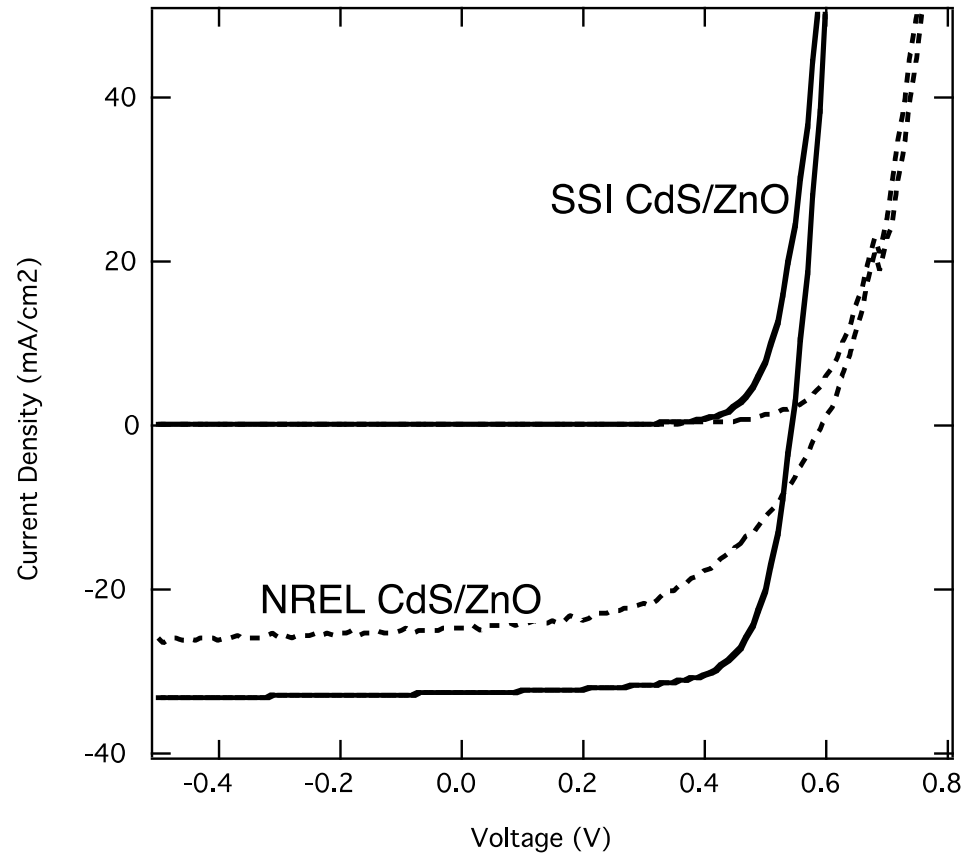
ZnO

CIGSS



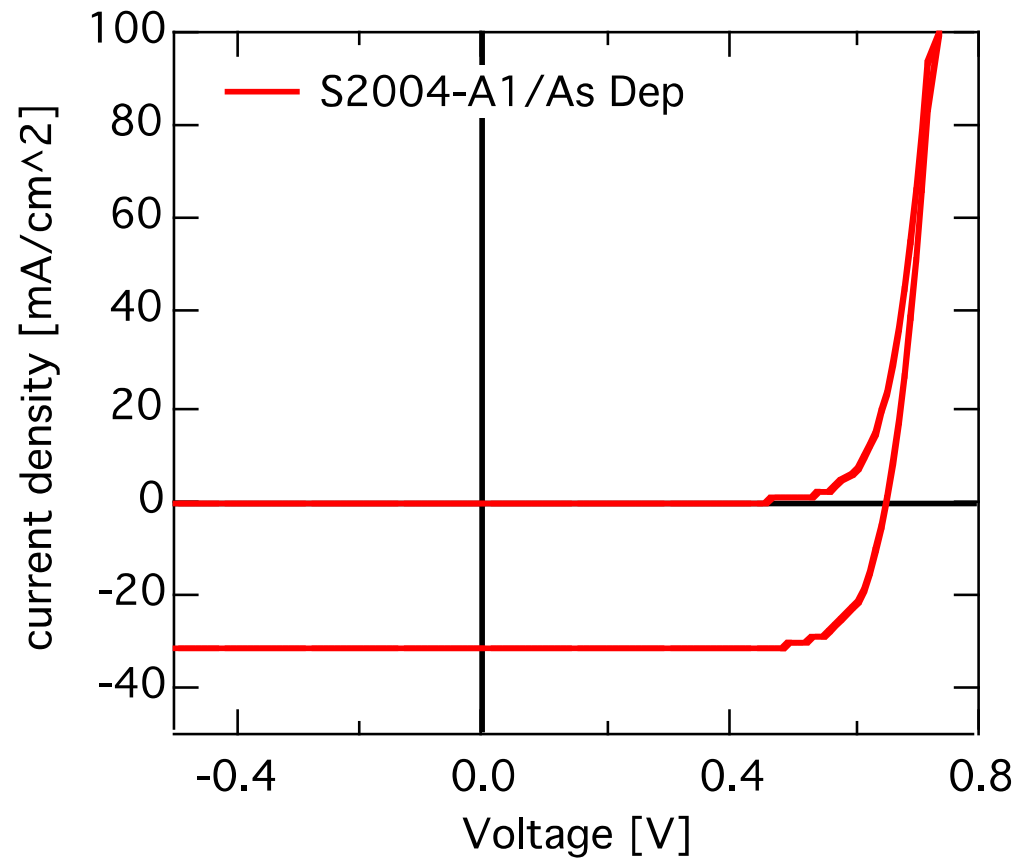


# Example 1: SSI Absorber deviation



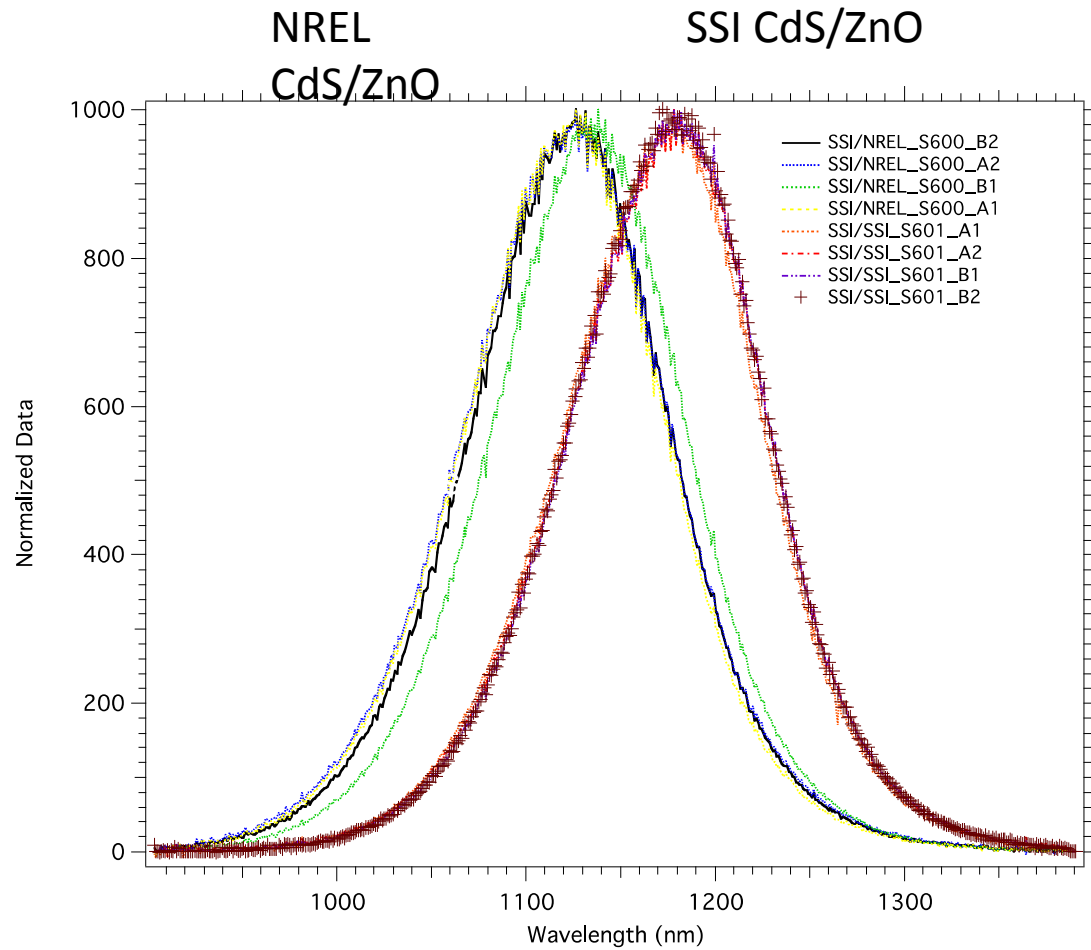
Common absorber  
Lower performance with  
NREL CdS/ZnO  
(not typical)

K. Ramanathan, CIS National Team, 2002



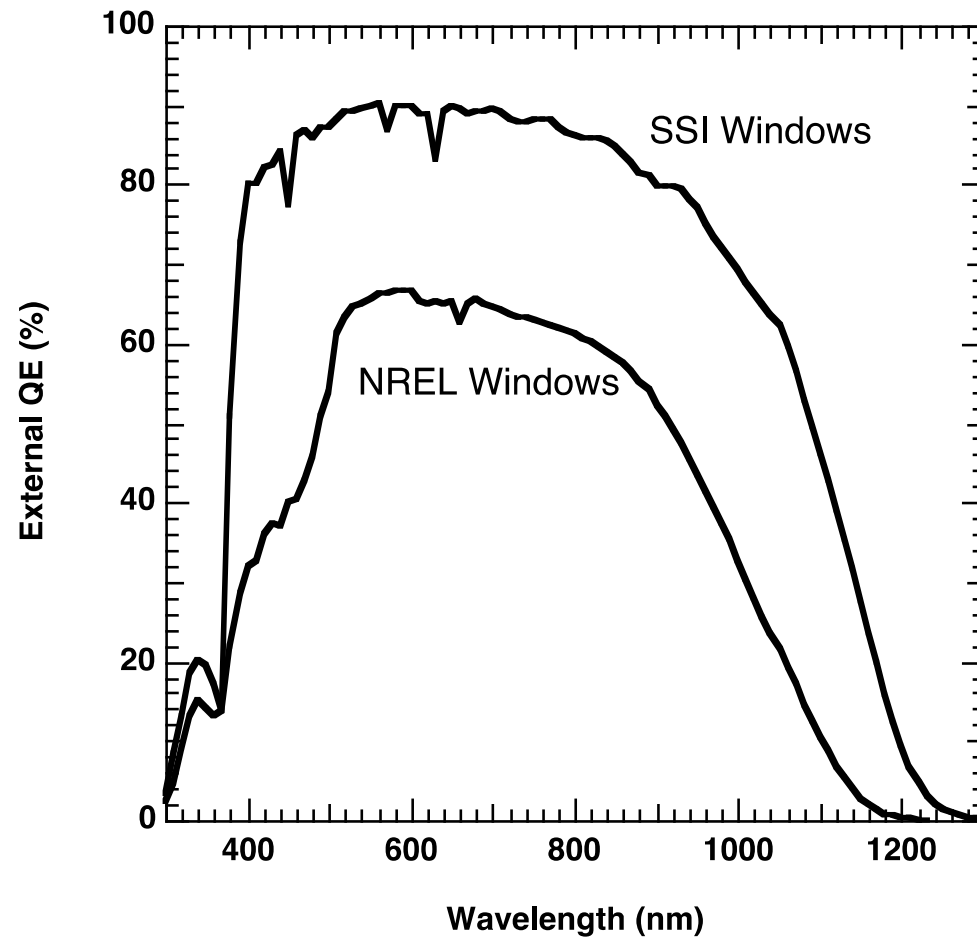
NREL  
absorber/  
windows OK!

# PL Spectra

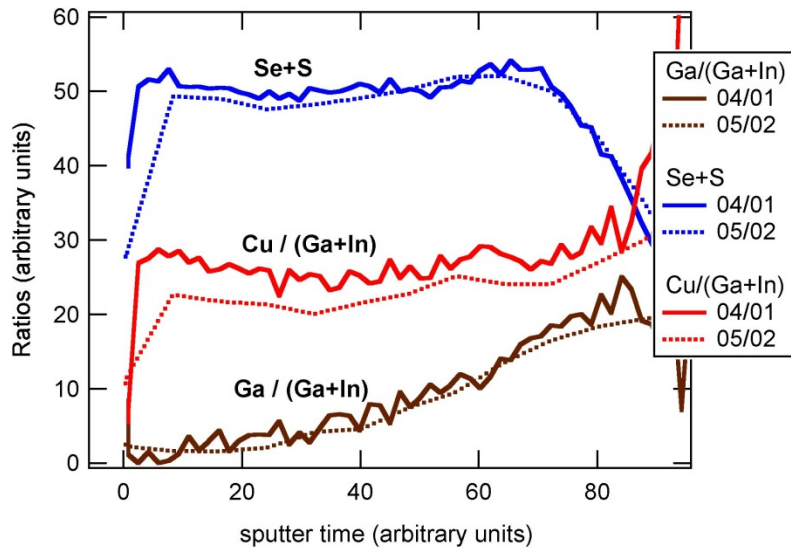
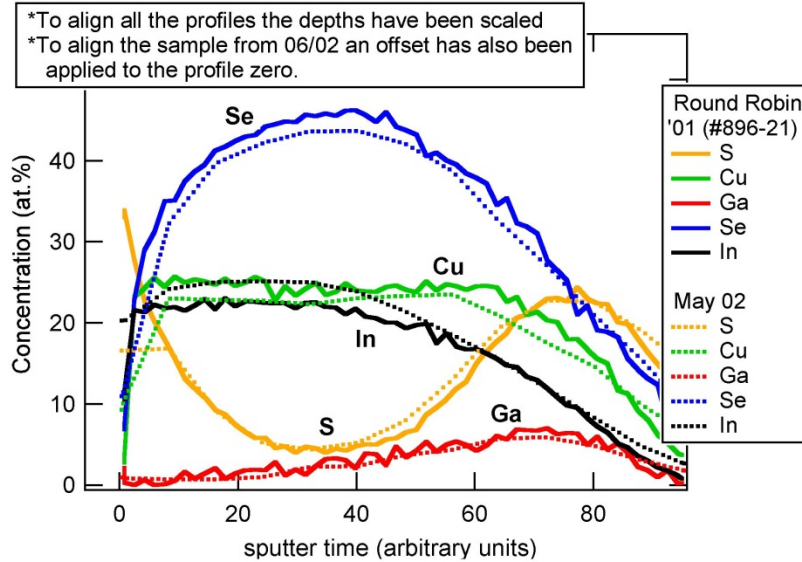


# Quantum efficiency

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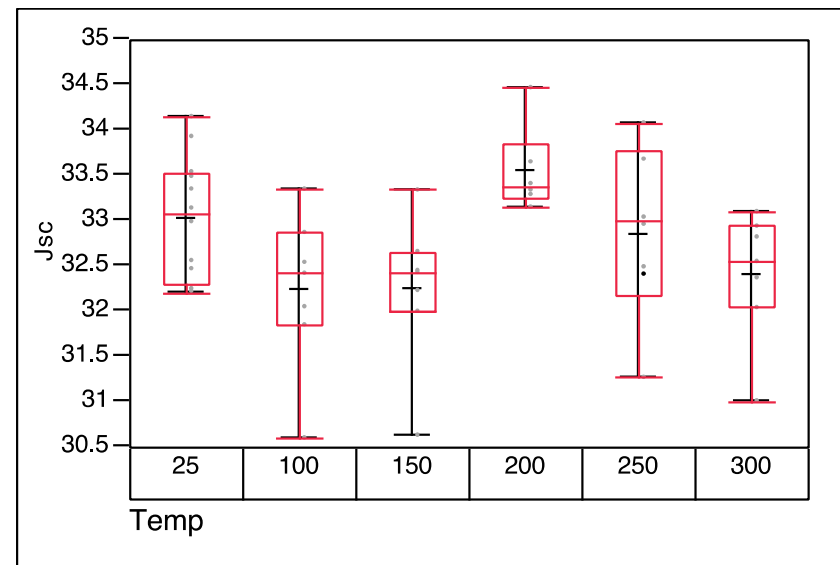
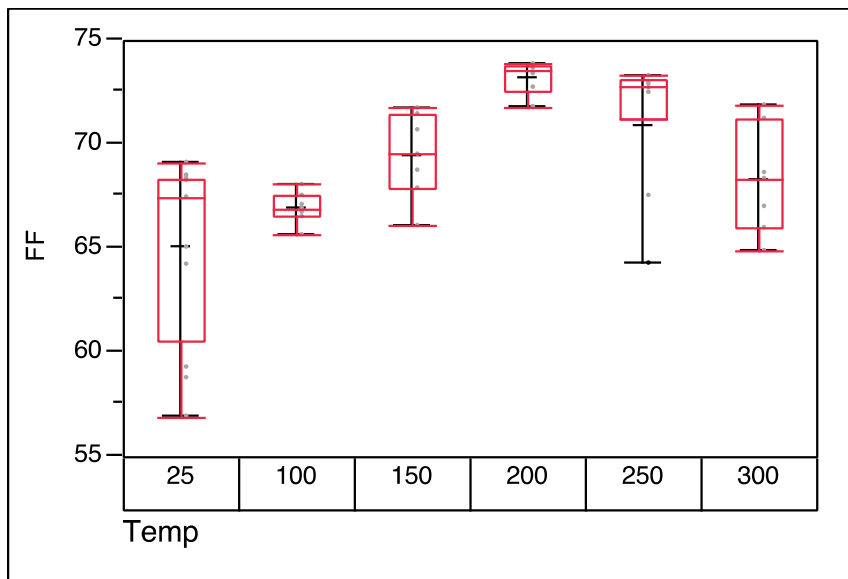
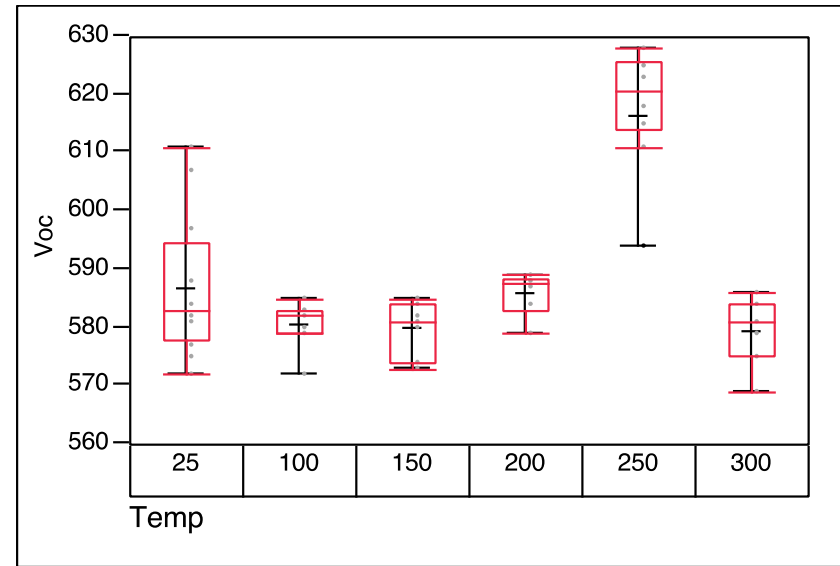
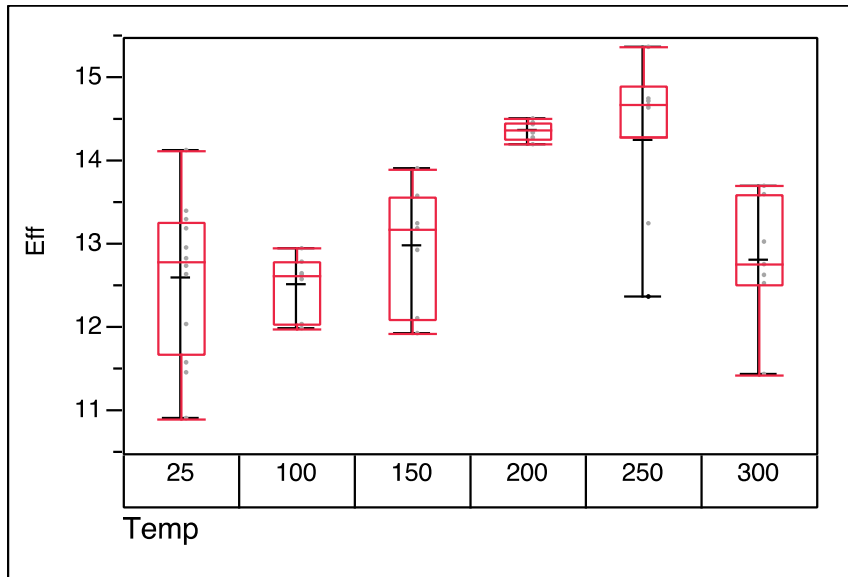


# Compositional analysis



Revealed a large drop in the Cu ratio for the batch of absorbers.

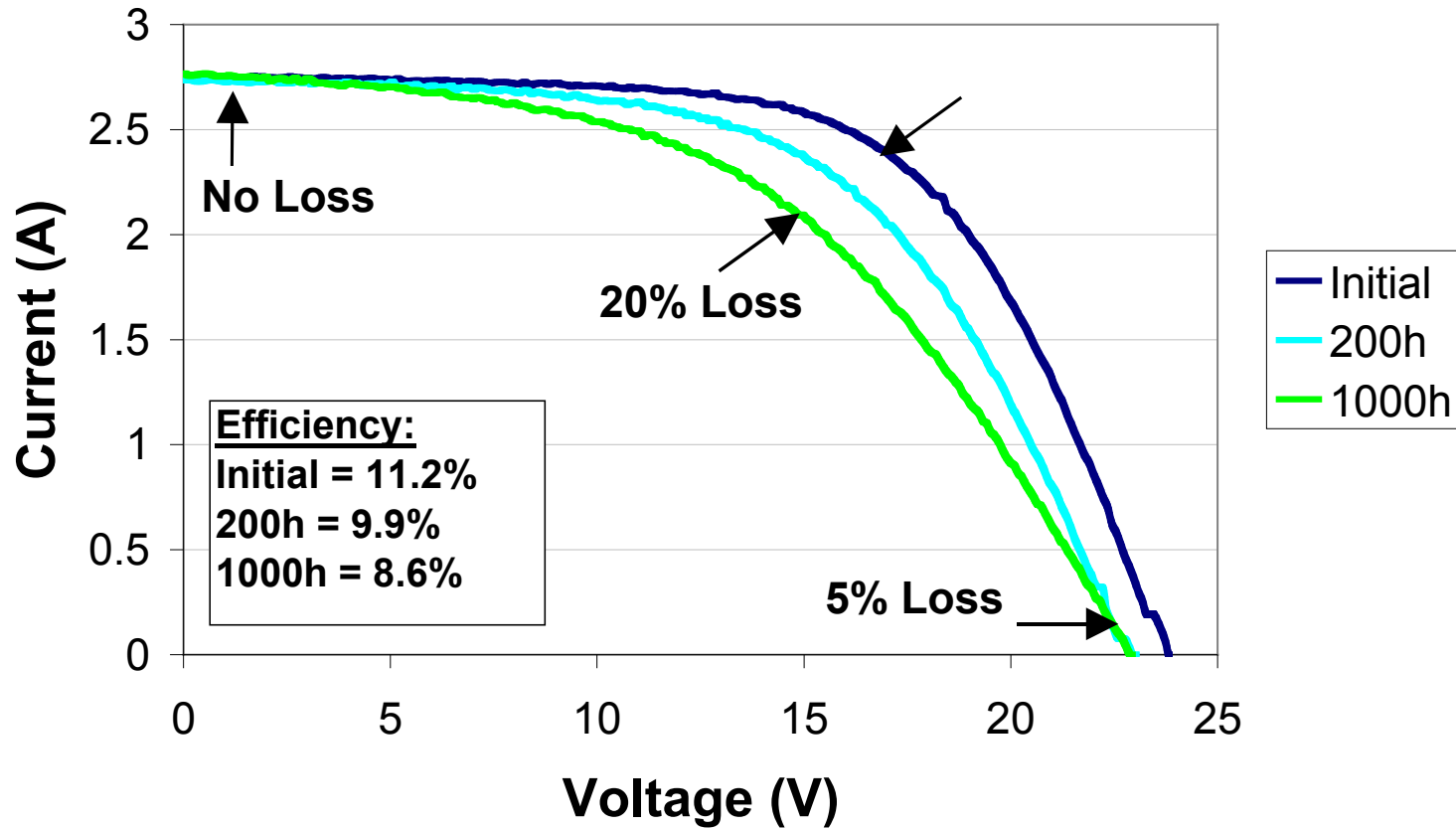
## Example 2: Junction anneal to improve performance



K. Ramanathan, NREL, 2002, unpublished

# Thermal Degradation Characteristics

## ST40 Module - Daystar Outdoor Tests

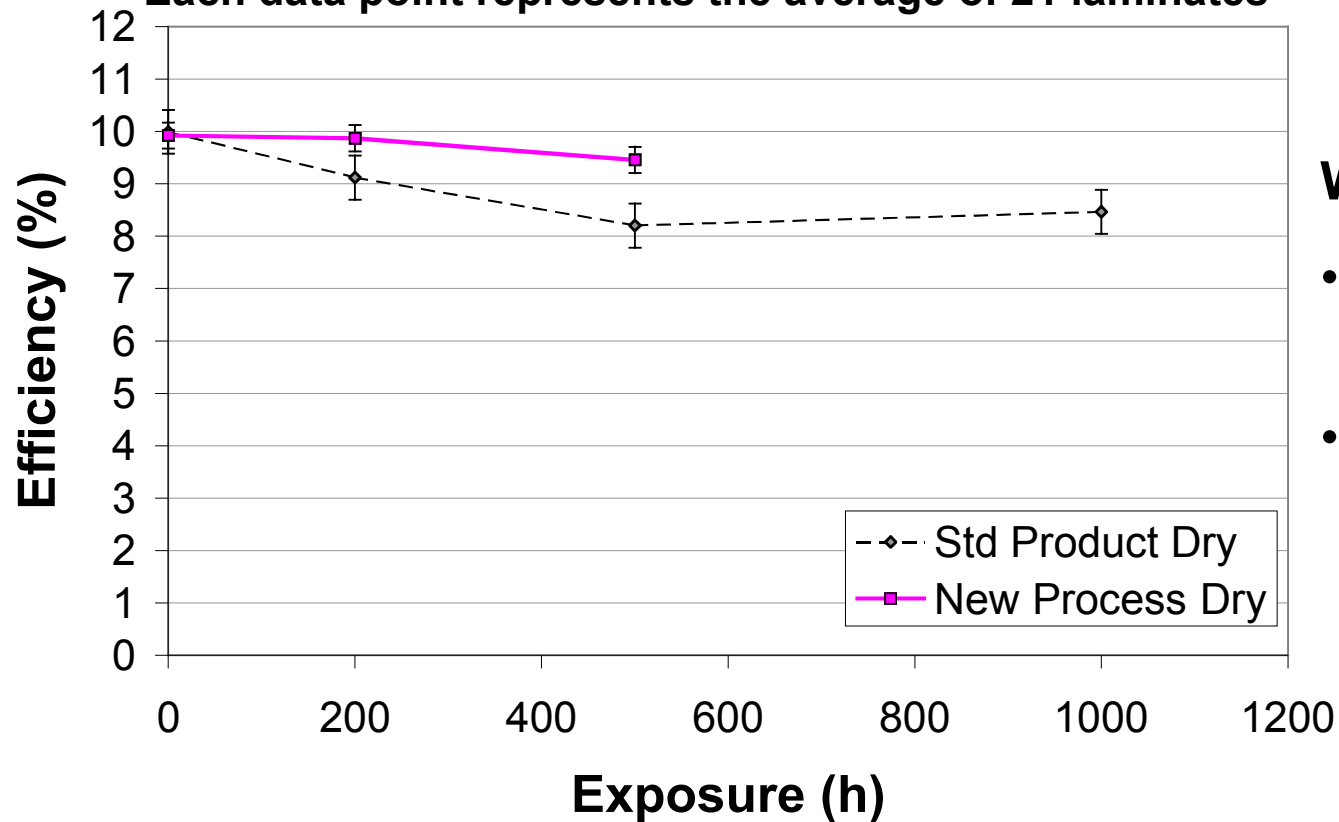


# Modified Processing for Thermal Stability

## Dry Heat Test Only

### 10W Laminates - LAPSS Test

Each data point represents the average of 21 laminates



What was changed?

- Increased CdS thickness
- Low CIG ratio





# Summary

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- **Proper encapsulation of CIGS devices can alleviate much of the moisture driven performance degradation.**
- **It is possible the high efficiency devices exhibit fewer metastable effects. Efficiency improvement efforts may pay off in stability.**
- **A case by case approach is needed to optimize devices for performance and long term stability.**

# Note added March 5, 2012

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- Important questions were raised in the afternoon discussion session that call for clarifications and further work on how CIGS devices are affected by moisture.
- Siemens/ Shell Gen II arrays have demonstrated stable operation at the OTF.
- A recent NREL study of Shell's Eclipse 80 modules showed excellent stability and negligible effect of moisture because of improved packaging and edge seals. A paper that just appeared [Solar Energy Materials & Solar Cells 98 (2012) 398–403 ] showed that a new edge seal design enabled stable performance for 3000 h in damp heat.
- It is not possible to draw definitive conclusions about the moisture sensitivity of CIGS based on the available reports on unencapsulated cells.